Two Department faculty and CSE alumni receive patent

Professors Lawrence Hall, Dmitry Goldgof and Peter Mouton along with CSE alumni Dr. Kurt Kramer, Dr. Baishali Chaudhuri, Daniel Elozory, and Pavinthra Bonam were granted United States Patent entitled “Automatic Stereological Analysis of Biological Tissue including Section Thickness Determination (No. 9,297,995, granted on March 29, 2016). This patent is part of long term research collaboration in microscopy image analysis between USF Department of Computer Science and Engineering, USF Health Byrd Alzheimer’s Institute, and The Stereology Resource Center (SRC).